

PUTs

Planar, TO-18, Hermetic

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2N6119-2N6120

T-25-09

FEATURES

- Hermetically Sealed TO-18 Metal Can
- Programmable η , R_{BB} , I_p , and I_v
- Maximum Peak Point Current: 150nA
- Minimum Valley Current to 1.5mA
- Nano-Amp Leakage
- Passivated Planar Construction for Maximum Reliability and Parameter Uniformity

DESCRIPTION

Functionally equivalent to standard unijunction transistors, Unitrode's Programmable Unijunction Transistors offer the distinct advantage of versatile programming. External resistors can be added to meet the designer's needs in programming η , R_{BB} , I_p and I_v functions. This series also features a hermetically sealed TO-18 package for optimum reliability in all environmental conditions. Applications include pulse and timing circuits, SCR trigger circuits, relaxation oscillators and sensing circuits. For additional information see Unitrode Application Note U-66.

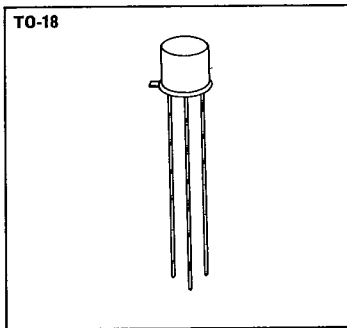
ABSOLUTE MAXIMUM RATINGS

| | | |
|--|-------|-----------------|
| Anode-to-Cathode Voltage, V_{AK} | | $\pm 40V$ |
| Gate-to-Cathode Forward Voltage, V_{GK} | | 40V |
| Gate-to-Anode Reverse Voltage, V_{GAR} | | 40V |
| Gate-to-Cathode Reverse Voltage, V_{GKR} | | -5V |
| Peak Recurrent Forward Current | | |
| 10 μ s, 1% Duty Cycle | | 8A |
| 100 μ s, 1% Duty Cycle | | 5A |
| Power Dissipation | | |
| 25°C Ambient | | 400mW |
| Derating Factor | | 3.2mW/°C |
| Storage Temperature | | -55°C to +125°C |
| Operating Temperature Range | | -55°C to +125°C |

MECHANICAL SPECIFICATIONS

2N6119-2N6120

| | INCHES | MILLIMETERS |
|---|----------------------------|------------------|
| A | 178-195 DIA. | 4.52-4.95 DIA |
| B | .170-210 | 4.31-5.33 |
| C | 5 MIN. | 12.70 MIN. |
| D | .209-230 DIA. | 5.31-5.84 DIA |
| E | 017 ± 002 DIA. 001 DIA' | 432 ± 025 |
| F | 020 MAX. | .508 MAX. |
| G | .100 ± 010 DIA. | 2.54 ± 2.54 DIA. |
| H | 041 ± 005 | 1.04 ± .127 |
| J | 028-.048 | .711-1.22 |

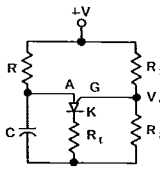


ELECTRICAL SPECIFICATIONS (at 25°C unless noted)

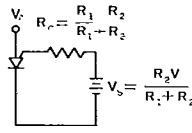
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| Test | Symbol | Fig. | 2N6119 | | 2N6120 | | Units | Test Conditions |
|---------------------------|-----------|------|------------|------------|------------|-------------|--------------------------|---|
| | | | Min. | Max. | Min. | Max. | | |
| Peak Current | I_P | 1 | — | 5 2 | — | 1.0 0.15 | μA μA | $R_G = 10k, V_S = 10V$ $R_G = 1 Meg.$ |
| Valley Current | I_V | 1 | 70 1.5 | — 50 | 25 1.0 | — 25 | μA μA mA | $R_G = 10k, V_S = 10V$ $R_G = 1 Meg.$ $R_G = 200\Omega$ |
| Offset Voltage | V_T | 1 | 0.2 0.2 | 0.6 1.6 | 0.2 0.2 | 0.6 0.6 | V V | $R_G = 10k, V_S = 10V$ $R_G = 1 Meg.$ |
| Gate-to-Anode Leakage | I_{GAO} | 2 | — | 10 100 | — | 10 100 | nA nA | $T = 25^\circ C, V_S = 40V$ $T = 75^\circ C$ |
| Gate-to-Cathode Leakage | I_{GKS} | 3 | — | 100 | — | 100 | nA | $V_S = 40V$ |
| Forward Voltage | V_F | 4 | — | 1.0 | — | 1.0 | V | $I_F = 50mA$ |
| Pulse Output Voltage | V_o | 5 | 9 | — | 9 | — | V | |
| Pulse Output Rate of Rise | t_r | 5 | — | 80 | — | 80 | ns | |

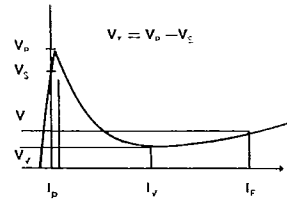
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a) Typical Circuit



b) Equivalent Test Circuit



c) Characteristic Curve

Figure 1

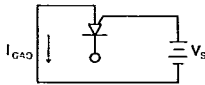


Figure 2

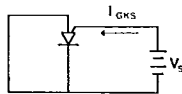


Figure 3

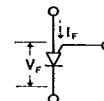


Figure 4

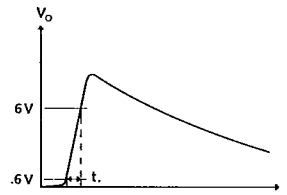
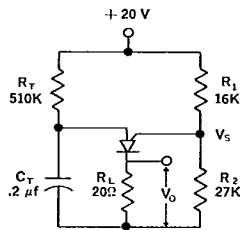
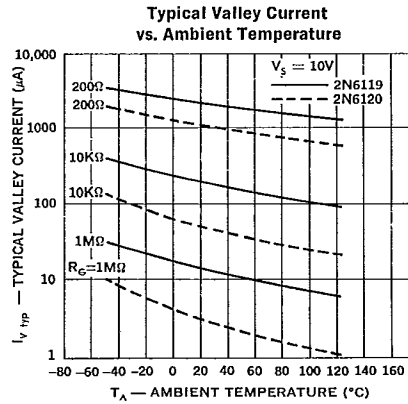
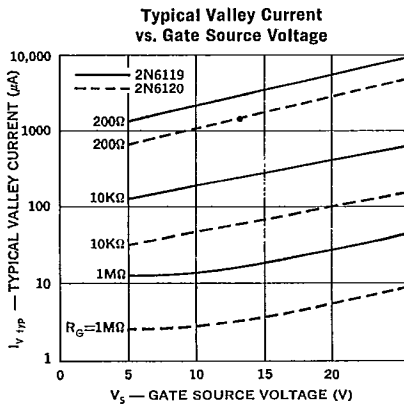
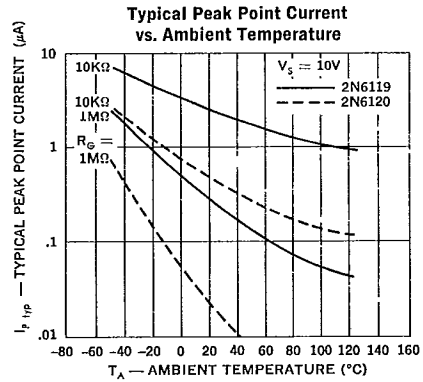
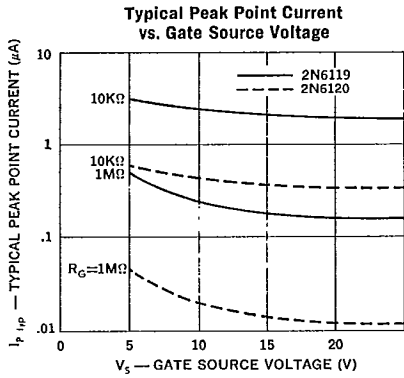


Figure 5

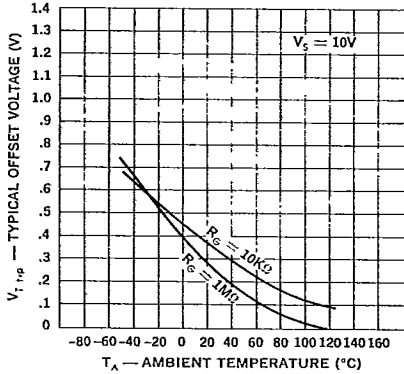
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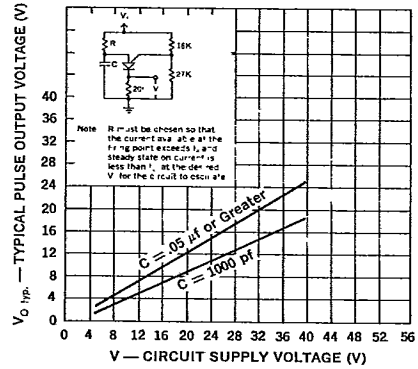


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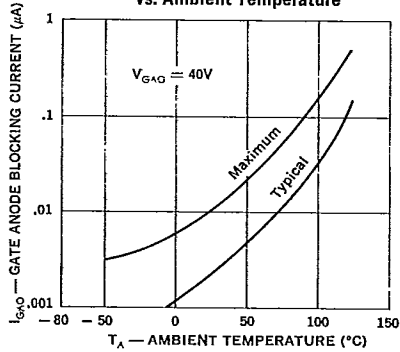
Typical Offset Voltage vs. Ambient Temperature



Typical Pulse Output vs. Circuit Supply Voltage



Gate-Anode Blocking Current vs. Ambient Temperature



Typical On-State Current vs. Voltage

